S	earch Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination
10/537,017	AZEVEDO ET AL.
Examiner	Art Unit
Samuel W. Liu	1656

SEARCHED					
Class	Subclass	Date	Examiner		
		-			

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
		•				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STN search for Pseudomonas fluorescens /WH6 or B-30485 bacterial strain.	8/29/2007	SWL		
WEST search for Pseudomonas fluorescens /WH6 or B-30485/germination arrest factor/germination/weeds.	8/29/2007	SWL		
eDAN and PALM inventor name search, and review 60431651.	8/29/2007	SWL		